

TEST REPORT

Applicant:	Woan Technology (Shenzhen) Co., Ltd.						
Address:	Room 1101, Qiancheng Commercial Center, No. 5 Haicheng Road, Mabu Community, Xixiang Sub- district, Bao'an District, Shenzhen, Guangdong, P.R. China, 518100						
Equipment Type:	SwitchBot Lock Pro						
Model Name:	W3500000 (refer to section 2.3)						
Brand Name:	SwitchBot						
HVIN Number	W3500000, W3500001, W3500004						
FCC ID:	2AKXB-W3500000						
Test Standard:	47 CFR Part 2.1091 KDB 447498 D04 v01						
Sample Arrival Date:	Sep. 18, 2023						
Test Date:	Sep. 19, 2023 - Jan. 08, 2024						
Date of Issue:	Jan. 18, 2024						

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.

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Revision History Version Issue Date Revisions Content Rev. 01 Jan. 18, 2024 Initial Issue TABLE OF CONTENTS TABLE OF CONTENTS 1 GENERAL INFORMATION. 3 1.1 Test Laboratory 3 1.2 Test Location 3 2 PRODUCT INFORMATION 4 2.1 Applicant Information 4 2.2 Manufacturer Information 4 2.3 General Description for Equipment under Test (EUT) 4 2.4 Technical Information 4 3 SUMMARY OF TEST RESULT 5 3.1 Test Standards 5 4 DEVICE CATEGORY AND LEVELS LIMITS 6	_					
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1 GENERAL INFORMATION

1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.					
Address	Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road,					
	Nanshan District, Shenzhen, Guangdong Province, P. R. China					
Phone Number	+86 755 6685 0100					

1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	Block B, 1/F, Baisha Science and Technology Park, Shahe Xi
	Road, Nanshan District, Shenzhen, Guangdong Province, P. R.
	China
	1/F, Building B, Ganghongji High-tech Intelligent Industrial Park,
	No. 1008, Songbai Road, Yangguang Community, Xili Sub-district,
	Nanshan District, Shenzhen, Guangdong Province, P. R. China
Accreditation	The laboratory is a testing organization accredited by FCC as a
Certificate	accredited testing laboratory. The designation number is CN1196.



2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	Woan Technology (Shenzhen) Co., Ltd.			
	Room 1101, Qiancheng Commercial Center, No. 5 Haicheng Road,			
Address	Mabu Community, Xixiang Sub-district, Bao'an District, Shenzhen,			
	Guangdong, P.R. China, 518100			

2.2 Manufacturer Information

Manufacturer	Woan Technology (Shenzhen) Co., Ltd.			
	Room 1101, Qiancheng Commercial Center, No. 5 Haicheng Road,			
Address	Mabu Community, Xixiang Sub-district, Bao'an District, Shenzhen,			
	Guangdong, P.R. China, 518100			

2.3 General Description for Equipment under Test (EUT)

EUT Name	SwitchBot Lock Pro				
Model Name Under Test	W350000				
Series Model Name	W3500001, W3500002, W3500003, W3500004, W3500005				
Description of Model name differentiation	All models are same with electrical parameters and internal circuit structure, but only differ in model name and different accessories. (this information provided by the applicant)				
HVIN Number	W350000, W3500001, W3500004				
Hardware Version	V01				
Software Version	V1.0				
Dimensions (Approx.)	N/A				
Weight (Approx.)	N/A				

2.4 Technical Information

Network and Wireless	Bluetooth (BLE)
connectivity	Bidelootin (BEE)

The requirement for the following technical information of the EUT was tested in this report:

Operating Mode	Bluetooth	Bluetooth			
Frequency Range	Bluetooth 2400 ~ 2483.5 MHz				
Antenna Type	Bluetooth PCB Antenna				
Exposure Category	General Population/Uncontrolled Exposure				
Product Type	Mobile Device				



3 SUMMARY OF TEST RESULT

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 2.1091	Radiofrequency radiation exposure evaluation: mobile devices
2	KDB 447498 D04 v01	447498 D04 Interim General RF Exposure Guidance v01



4 DEVICE CATEGORY AND LEVELS LIMITS

Mobile Devices:

CFR Title 47 §2.1091(b)

(b) For purposes of this section, a mobile device is defined as a transmitting device designed to be used in other than fixed locations and to generally be used in such a way that a separation distance of at least 20 centimeters is normally maintained between the transmitter's radiating structure(s) and the body of the user or nearby persons.

FCC KDB 447498 D04 General RF Exposure Guidance v01 Limit

Evaluation of compliance with the exposure limits in § 1.1310 is necessary if the ERP of the device is greater than ERP20cm in Formula (B.1) [repeated from § 2.1091(c)(1) and § 1.1307(b)(1)(i)(B)].

 $P_{\rm th} (\rm mW) = ERP_{20 \,\rm cm} (\rm mW) = \begin{cases} 2040f & 0.3 \,\rm GHz \le f < 1.5 \,\rm GHz \\ 3060 & 1.5 \,\rm GHz \le f \le 6 \,\rm GHz \end{cases}$ (B.1)

If the ERP is not easily obtained, then the available maximum time-averaged power may be used (i. e., without consideration of ERP only if the physical dimensions of the radiating structure(s) do not exceed the electrical length of $\lambda/4$ or if the antenna gain is less than that of a half-wave dipole.

SAR-based exemptions are constant at separation distances between 20 cm and 40 cm to avoid discontinuities in the threshold when transitioning between SAR-based and MPE-based exemption criteria at 40 cm, considering the importance of reflections.

The SAR-based exemption formula of § 1.1307(b)(3)(i)(B), repeated here as Formula (B.2), applies for single fixed, mobile, and portable RF sources with available maximum time-averaged power or effective radiated power (ERP), whichever is greater, of less than or equal to the threshold Pth (mW).

This method shall only be used at separation distances from 0.5 cm to 40 cm and at frequencies from 0.3 GHz to 6 GHz (inclusive). Pth is given by Formula (B.2).



$$P_{\rm th} (\rm mW) = \begin{cases} ERP_{20 \,\rm cm} (d/20 \,\rm cm)^x & d \le 20 \,\rm cm \\ \\ ERP_{20 \,\rm cm} & 20 \,\rm cm < d \le 40 \,\rm cm \end{cases}$$
(B.2)

where

$$x = -\log_{10}\left(\frac{60}{ERP_{20}\operatorname{cm}\sqrt{f}}\right)$$

and f is in GHz, d is the separation distance (cm), and ERP_{20cm} is per Formula (B.1). The example values shown in Table B.2 are for illustration only.

		10						ioius (ii	1)		
					Dis	stance	(mm)				
		5	10	15	20	25	30	35	40	45	50
	300	39	65	88	110	129	148	166	184	201	217
(MHz)	450	22	44	67	89	112	135	158	180	203	226
	835	9	25	44	66	90	116	145	175	207	240
enc	1900	3	12	26	44	66	92	122	157	195	236
Frequency	2450	3	10	22	38	59	83	111	143	179	219
Fn	3600	2	8	18	32	49	71	96	125	158	195
	5800	1	6	14	25	40	58	80	106	136	169

Table B.2-Example Power Thresholds (mW)



ASSESSMENT RESULT 5

5.1 Output Power

Mode	Bluetooth			
Conducted Power (dBm)	2.99			
Antenna Gain (dBi)	-0.45			
EIRP (dBm) 2.54				
Note: This report listed the maximal case power value, please refer to BL-SZ2390804-601 report for more details.				

5.2 Tune-up power

Mode	Conducted Power Range (dBm)	EIRP Range (dBm)	ERP Range (dBm)					
Bluetooth	[1.00, 3.00]	[1.00, 3.00]	[-1.15, 0.85]					
Note1: ERP= EIRP -2.15dB.								
Note2: According KDB 447498 D04, used the greater of maximum conducted power and ERP to compare with the threshold								
value Pth.								

5.3 RF Exposure Evaluation Result

Evolution mode	Maximum power	Maximum power	Distance	Threshold Power	Verdict	
	(dBm)	(mw)	(mm)	(mW)	verdict	
Bluetooth	3.00	2.00	200	3060.00	Pass	

5.4 Conclusion

This EUT is deemed to comply with the reference level limits, therefore the basic restrictions are compliant with human exposure limits.



Statement

1. The laboratory guarantees the scientificity, accuracy and impartiality of the test, and is responsible for all the information in the report, except the information provided by the customer. The customer is responsible for the impact of the information provided on the validity of the results.

2. The report without China inspection body and laboratory Mandatory Approval (CMA) mark has no effect of proving to the society.

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7. Any objection shall be raised to the laboratory within 30 days after receiving the report.

--END OF REPORT--